New Jersey Semi-Conductor Products, Inc.

20 STERN AVE. SPRINGFIELD, NEW JERSEY 07081 U.S.A. TELEPHONE: (973) 376-2922 (212) 227-6005 FAX: (973) 376-8960



Rating		Symbol	Value		Unit
Drain-Source Voltage		V <sub>DSS</sub>	6	5	Vdc
Drain-Gate Voltage (R <sub>GS</sub> = 1.0 MΩ)		V <sub>DGR</sub>	6	5	Vdc
Gate-Source Voltage		V <sub>GS</sub>	±4	10	Vdc
Drain Current — Continuous		łD	2	6	Adc
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C		PD	400 2.27		Watts W/°C
Storage Temperature Range		T <sub>stg</sub>	-65 to	+150	°C
Operating Junction Temperature		Tj	200		°C
THERMAL CHARACTERISTICS					
Characteristic		Symbol	Mi	x	Unit
Thermal Resistance, Junction to Case		R <sub>eJC</sub>	0.44		°C/W
ELECTRICAL CHARACTERISTICS (T <sub>c</sub> = 25°C unle	ss otherwise noted)				
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS (1)					
Drain-Source Breakdown Voltage (V <sub>GS</sub> = 0, I <sub>D</sub> = 50 mA)	V <sub>(BR)DSS</sub>	65		-	Vdc
Zero Gate Voltage Drain Current ( $V_{DS} = 28 V, V_{GS} = 0$ )	IDSS	-	_	2.5	mAdc
Gate-Source Leakage Current	IGSS	- 1	_	1.0	μAdc

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## **Quality Semi-Conductors**

(V<sub>GS</sub> = 20 V, V<sub>DS</sub> = 0)

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Characteristic	Symbol	Min	Тур	Max	Unit	
ON CHARACTERISTICS (1)						
Gate Threshold Voltage (V <sub>DS</sub> = 10 V, I <sub>D</sub> = 100 mA)	V <sub>GS(th)</sub>	1.0	3.0	6.0	Vdc	
Drain-Source On-Voltage (V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.0 A)	V <sub>DS(on)</sub>	0.1	0.9	1.5	Vdc	
Forward Transconductance (V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2.5 A)	9fs	2.0	3.0		mhos	
DYNAMIC CHARACTERISTICS (1)						
Input Capacitance (V <sub>DS</sub> = 28 V, V <sub>GS</sub> = 0, f = 1.0 MHz)	Ciss		180		pF	
Output Capacitance (V <sub>DS</sub> = 28 V, V <sub>GS</sub> = 0, f = 1.0 MHz)	C <sub>oss</sub>	·	200		ρF	
Reverse Transfer Capacitance (V <sub>DS</sub> = 28 V, V <sub>GS</sub> = 0, f = 1.0 MHz)	Crss		20		pF	
UNCTIONAL CHARACTERISTICS - MRF175GV (2) (Figure	ə 1)					
Common Source Power Gain (V <sub>DD</sub> = 28 Vdc, P <sub>out</sub> = 200 W, f = 225 MHz, I <sub>DQ</sub> = 2.0 x 100 mA)	G <sub>ps</sub>	12	14	-	dB	
Drain Efficiency (V <sub>DD</sub> = 28 Vdc, P <sub>out</sub> = 200 W, f = 225 MHz, I <sub>DQ</sub> = 2.0 x 100 mA)	η	55	65		%	
Electrical Ruggedness $(V_{DD} = 28 \text{ Vdc}, P_{out} = 200 \text{ W}, f = 225 \text{ MHz}, I_{DQ} = 2.0 \text{ x} 100 \text{ mA},$ VSWR 10:1 at all Phase Angles)	Ψ	No Degradation in Output Power				

NOTES:

1. Each side of device measured separately.

2. Measured in push-pull configuration.



- C1 Arco 404, 8.0-60 pF
- C2, C3, C7, C8 1000 pF Chip
- C4, C9 0.1 µF Chip
- C5 180 pF Chip
- C6 100 pF and 130 pF Chips in Parallel
- C10 --- 0.47 µF Chip, Kernet 1215 or Equivalent L1 --- 10 Turns AWG #16 Enamel Wire, Close
- Wound, 1/4" I.D. - Ferrite Beads of Suitable Material for 12
- 1.5-2.0 µH Total Inductance

Board material - .062" fiberglass (G10), Two sided, 1 oz. copper,  $\varepsilon_r \cong 5$ Unless otherwise noted, all chip capacitors

are ATC Type 100 or Equivalent.

R1 - 100 Ohms, 1/2 W

- R2 --- 1.0 k Ohm, 1/2 W
- T1 4:1 Impedance Ratio RF Transformer. Can Be Made of 25 Ohm Semirigid Coax, 47-52 Mils O.D.
- T2 1:9 Impedance Ratio RF Transformer. Can Be Made of 15-18 Ohms Semirigid Coax, 62-90 Mils O.D.
- NOTE: For stability, the input transformer T1 should be loaded with ferrite toroids or beads to increase the common mode inductance. For operation below 100 MHz. The same is required for the output transformer.



## Figure 1. 225 MHz Test Circuit